

Search Notes



Application/Control No.

10/751,638

Examiner

Dinh Q. Nguyen

Applicant(s)/Patent under
Reexamination

FLYNN ET AL.

Art Unit

3752

SEARCHED

Class	Subclass	Date	Examiner
239	417.5		
	406		
	416.5		
	423		
	434.5		
	429		
	533.2		
	533.12	9-16-04	DN
123	531		
	590		
	585	9-16-04	DN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EMF SEARCH ATTACHED		
REF 09/964,779		
10/286,843		
10/628,103		
	9-16-04	DN